

Search Notes

Application No.

09/396,244

Examiner

Cheukfan Lee

Applicant(s)

NAGANO, MASATOSHI

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
358	487, 475, 506, 509	11/22/2004	C.L.
	463,474		
355	30, 40, 41		
	67-71		
250	234-236		
382	312		
	318		
	319		
358	505		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
358	475, 487		
	506, 509		
	463, 474		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: (dust, scratch, foreign particle, defect\$3, contaminat\$3), (invisible, infrared, IR), (read\$3, scan\$5)	11/22/2004	C.L.
EAST search (cont.): (mode select\$5), skip\$5, (transparen\$5, film\$5, transmissive)		
EAST search (cont.): detect\$3 determin\$5 discriminat\$3		